

Stabilization of KEK-ATF RF gun

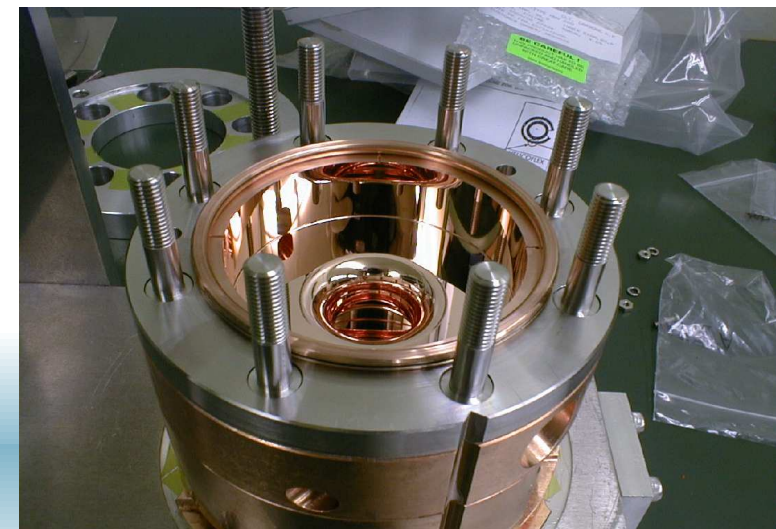
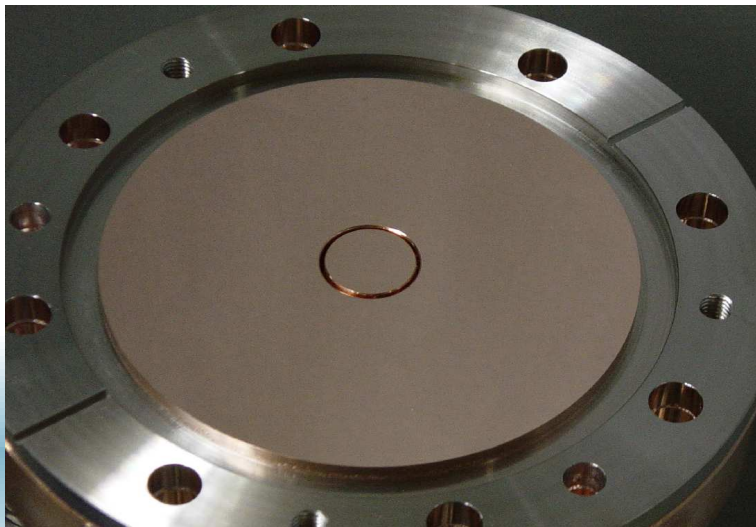
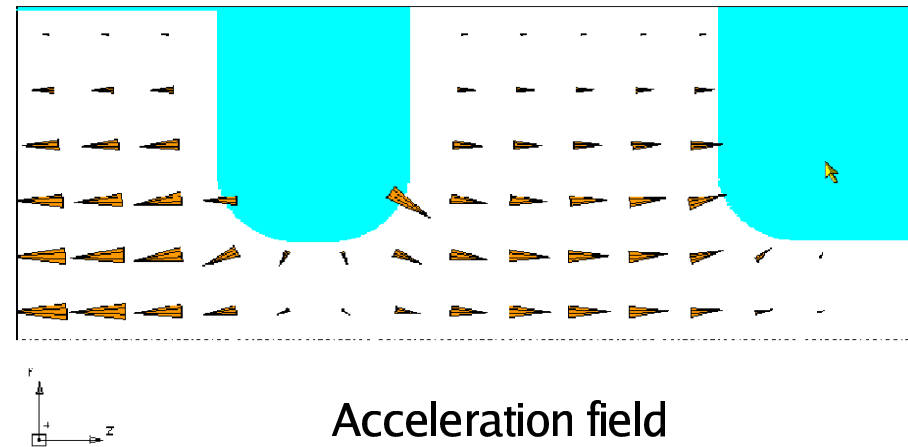
Kuriki Masao
for ATF collaboration

- ▲ ***Status of ATF RF-gun***
- ▲ ***QE in operation***
- ▲ ***Emission stabilization***
- ▲ ***Summary and future***

Powered by  **OpenOffice.org**

RF electron gun

- 1.6 cell BNL gun IV type.
- Pi mode acceleration.
- Cs₂Te cathode.



MB Laser Block Diagram

Mode-locked-laser

Nd:YVO₄, 1064nm, 357MHz,
410mW(CW)
Pulse length : 7.2ps(FWHM)
Timing jitter : < 0.5ps(rms)

Pockels cell

KD*P crystal
7kV maximum
Rise&Fall time <3nsec

Fast Pockels cell

3.4kV maximum
Rise time : < 1nsec
Double Pockels Cell

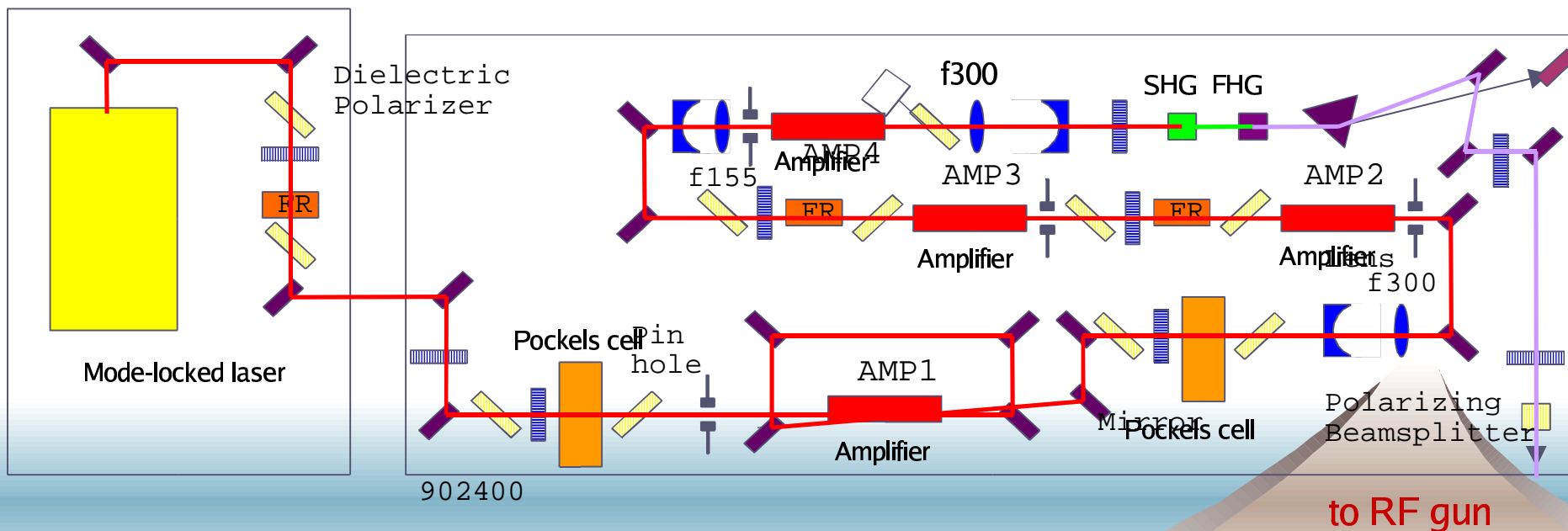
SHG

CASIX, β -BBO
6x6x6mm

FHG

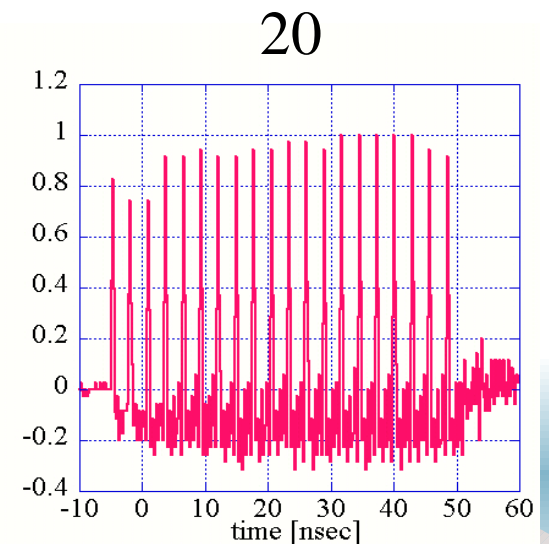
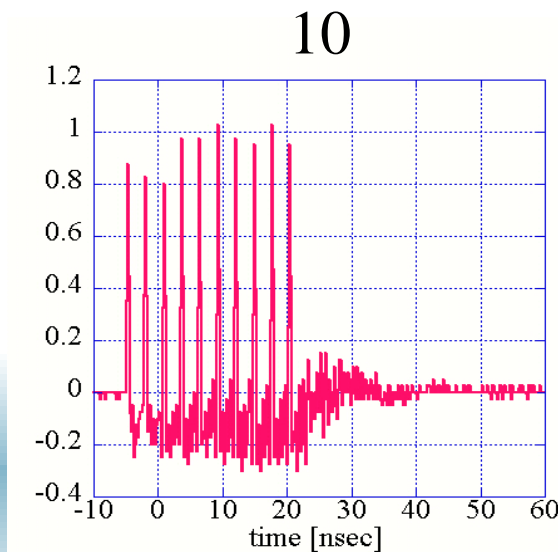
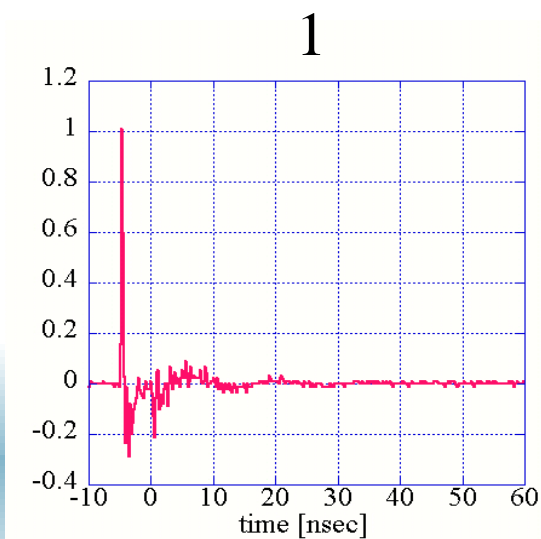
CASIX, β -BBO
6x6x6mm

UV light:
12ps(FWHM)
1 μ J/pulse



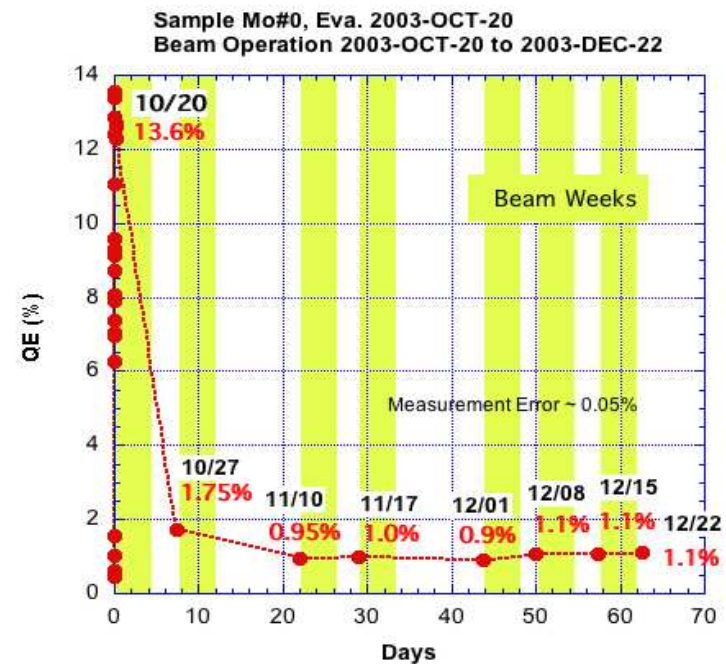
Pulse Clipping

- 357 MHz mode-lock laser generates continuous pulse train with 2.8 ns spacing.
- A part of the train is clipped out to make the multi-bunch (1 – 20) beam by the Pockels cells.
- The clipped pulse-train is amplified and converted to UV light.
- By shifting the clipping timing, any number of pulse from 1 to 20 can be obtained.



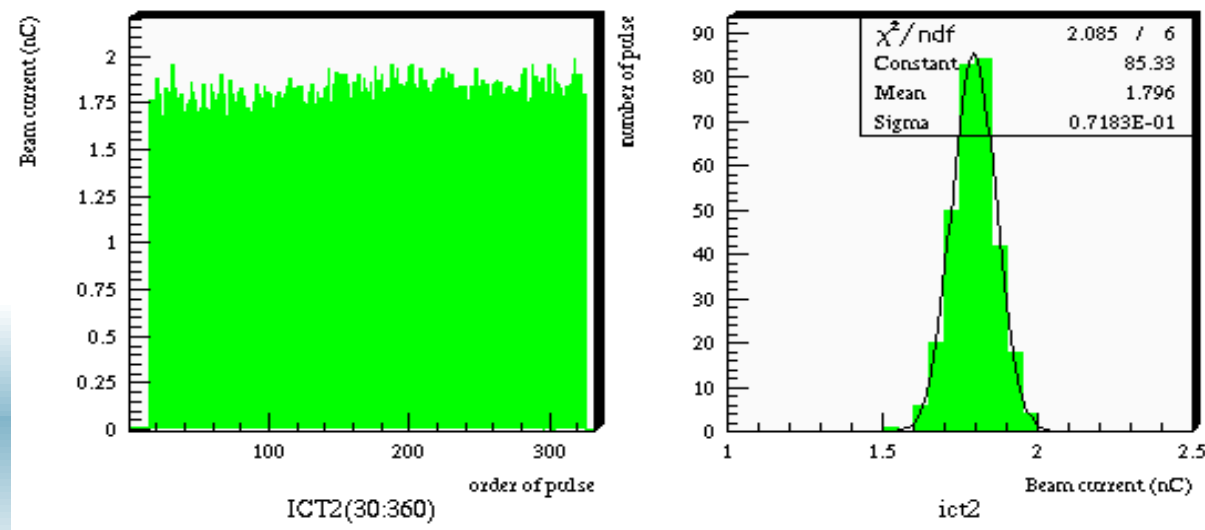
Status

- QE that was initially more than 10% was decreased rapidly and then kept around 1%.
- The emission did not change at least two months.
- Beam intensity : $0.1-3.0 \times 10^{10}$ electron/bunch
- Bunch number : 1-20



Status (2)

- Normalized emittance : 2-20 π mm.mrad
- Bunch length : 6.4 ~ 7.9 ps (sigma)
- Energy spread : $\Delta E/E = 1.0-3\%$ (FWHM)
- Intensity flatness in a train : 5 - 20% p-to-p
- Intensity fluctuation (pulse by pulse) : 5~10%
- Injection efficiency : can be 100%



QE in Operation

- Because QE is a function of the surface field, QE in operation is different from that at low surface field.
- QE in operation was extracted by observing the emission by varying the laser power.
- QE data were extrapolated toward zero surface field to compare that at zero surface field.

A Simple Model

Assuming Fermi-Dirac statistics and Shottky effect, emission from a photo-cathode

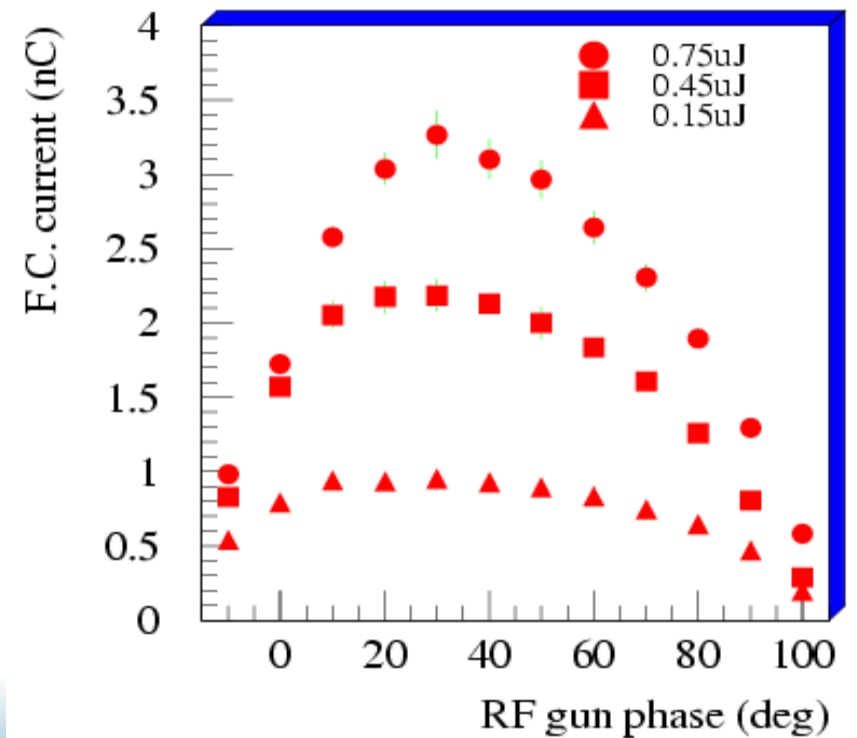
$$J = AT^2 \exp \left(\frac{h\nu - \phi_0 + \sqrt{e \beta E / 4 \pi \epsilon_0}}{kT} \right)$$

leads QE as function of the surface field;

$$QE(E) = QE_0 \exp \left(\frac{\sqrt{e \beta E / 4 \pi \epsilon_0}}{kT} \right)$$

Emission Vs RF Phase

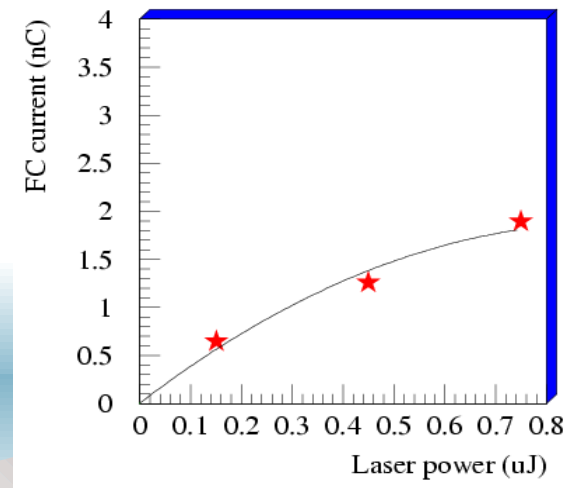
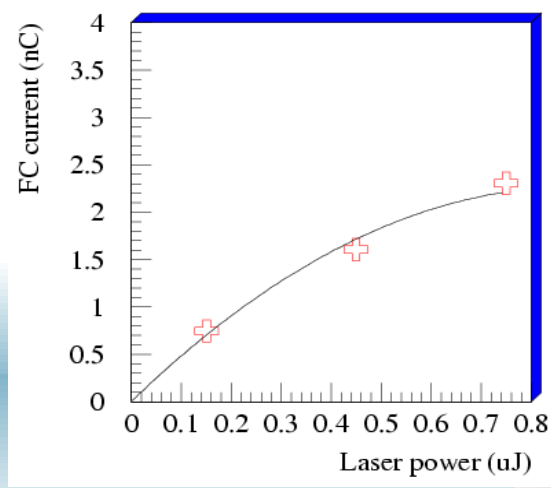
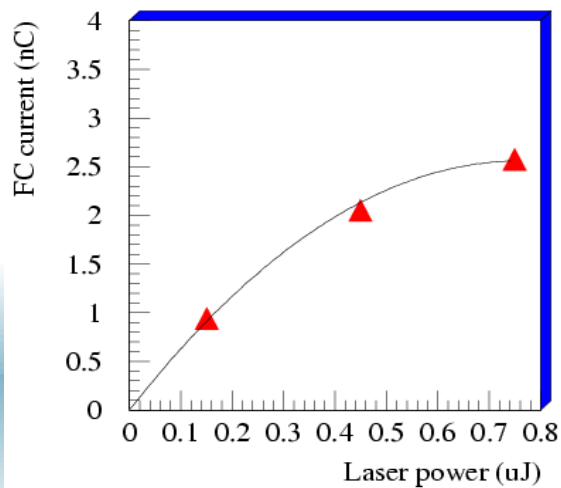
- Emission was measured by FC.
- Solenoid strength was optimized to maximized the emission for each point.
- The emission was measured for different laser power, 0.75, 0.45, 0.15 μJ .



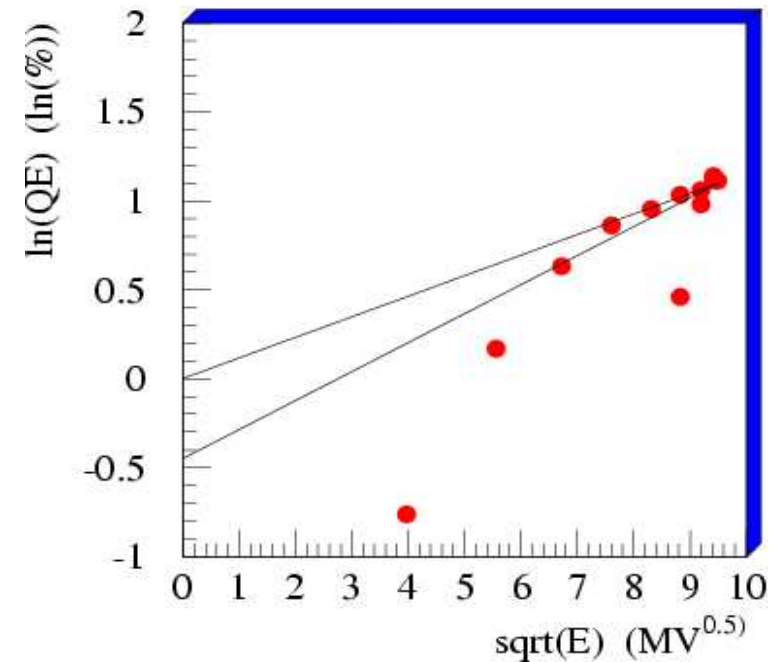
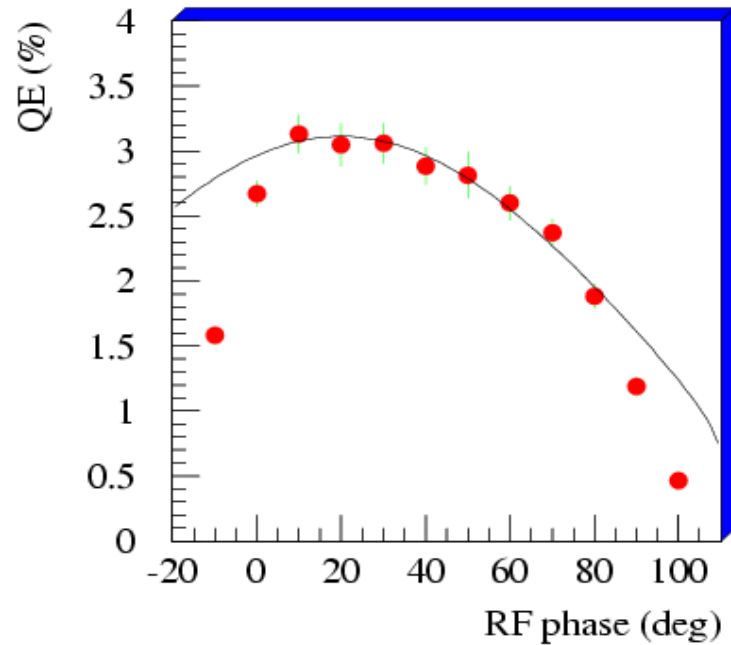
QE Extraction

- QE is defined as a ratio of numbers of illuminated photons and emitted electrons.
- The emission is however saturated by the surface and space charge limitation effects.
- QE at zero emission can be defined with its derivative as

$$QE(0) [\%] = \frac{123.8}{\lambda [nm]} \frac{\partial I [nC]}{\partial P [\mu J]}_{I=0}$$



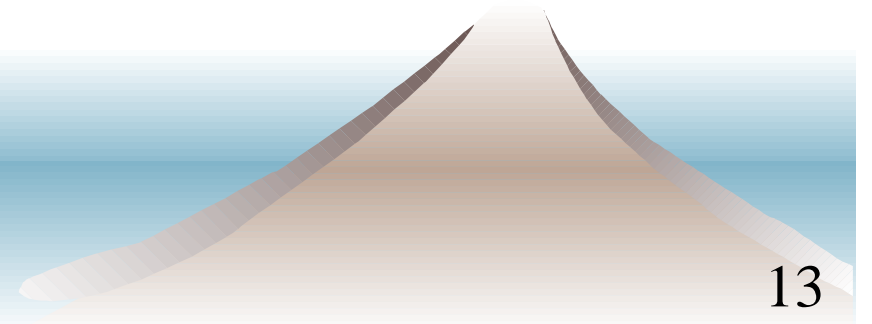
QE vs. Surface Field



- 1) QE at zero surface field : 0.64 ± 0.16 % that is not consistent to 1.0%.
- 2) A part of beam might be lost during the acceleration at the low field phase.

Surface Charge Limitation

- ▲ The emission from a photo-cathode is a function of the surface field as shown.
- ▲ The surface field is modified by a space charge near of the cathode surface.
- ▲ The emission is then suppressed by the localized space charge.
- ▲ The emission current will be saturated with a space charge that vanishes the surface field.



Formalism

Assuming a thin charge distribution and a purely perpendicular surface field on a cathode, the deceleration field E_{dec} by the space charge is expressed

$$E_{\text{dec}} = \frac{Q}{2\pi s_x^2}$$

where Q is total charge, s_x is beam radius. If the field is balanced to the acceleration field E_{acc} , the maximum extracted charge Q_{max} is

$$Q_{\text{max}} = 2\pi \sigma_x^2 \epsilon_0 E(t)$$

Emission stabilization

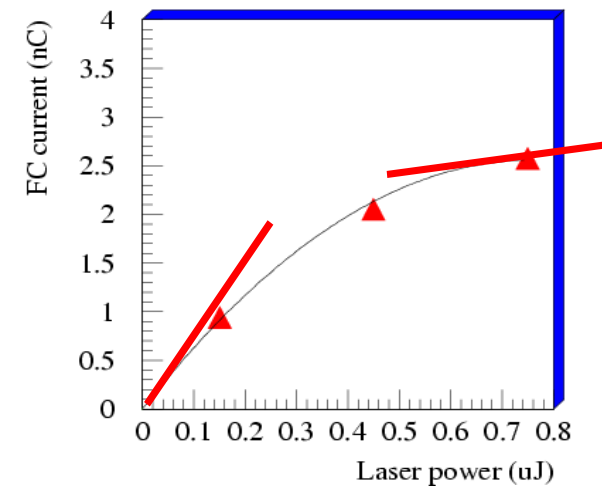
The maximum current is expressed with the practical units

$$Q_{\max} [\text{nC}] = \frac{E_{\text{acc}} [\text{MV/m}] \sigma_x^2 [\text{mm}]}{18}$$

By putting typical parameters of 100MV/m field and 0.5mm radius, the saturated emission becomes 1.4nC. The emission will be insensitive to the laser power in such condition.

Emission stabilization

- ▲ The emission can be stabilized by the saturation effect with the surface charge.
- ▲ To implement this method, we have to control the spot size and flatness of the laser light well.
- ▲ Even with a distorted laser spot, this mechanism can be used to compensate the intensity fluctuation due to the laser power jitter.
- ▲ This effect has been observed already in a real operation.



Summary

- CsTe RF gun in KEK-ATF is stably operated.
- By varying the laser power, QE in operation was measured. It was up to 3.0%.
- The surface field dependence of QE may be distorted by the transmission efficiency to FC.
- The significant surface charge limitation effect was observed. This effect potentially stabilizes the emission with a precise laser control.

Summary(2)

- ▲ Even with the current condition, the fluctuation due to the laser power jitter is compensated.
- ▲ A set of micro lenses array will be introduced as a intensity homogenizer.
- ▲ Real time laser power and profile monitors are planned.